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(71) Applicant *(for all designated States except US)*: **KONINKLIJKE PHILIPS ELECTRONICS N.V.** [NL/NL]; Groenewoudseweg 1, NL-5621 BA Eindhoven (NL).

(72) Inventors; and

(75) Inventors/Applicants *(for US only)*: **HENDRIKS, Robert, F., M.** [NL/NL]; c/o Prof. Holstlaan 6, NL-5656 AA Eindhoven (NL). **LENDERINK, Egbert** [NL/NL]; c/o Prof. Holstlaan 6, NL-5656 AA Eindhoven (NL).

(74) Agent: **COHEN, Julius, S.**; Philips Intellectual Property & Standards, Prof. Holstlaan 6, NL-5656 AA Eindhoven (NL).

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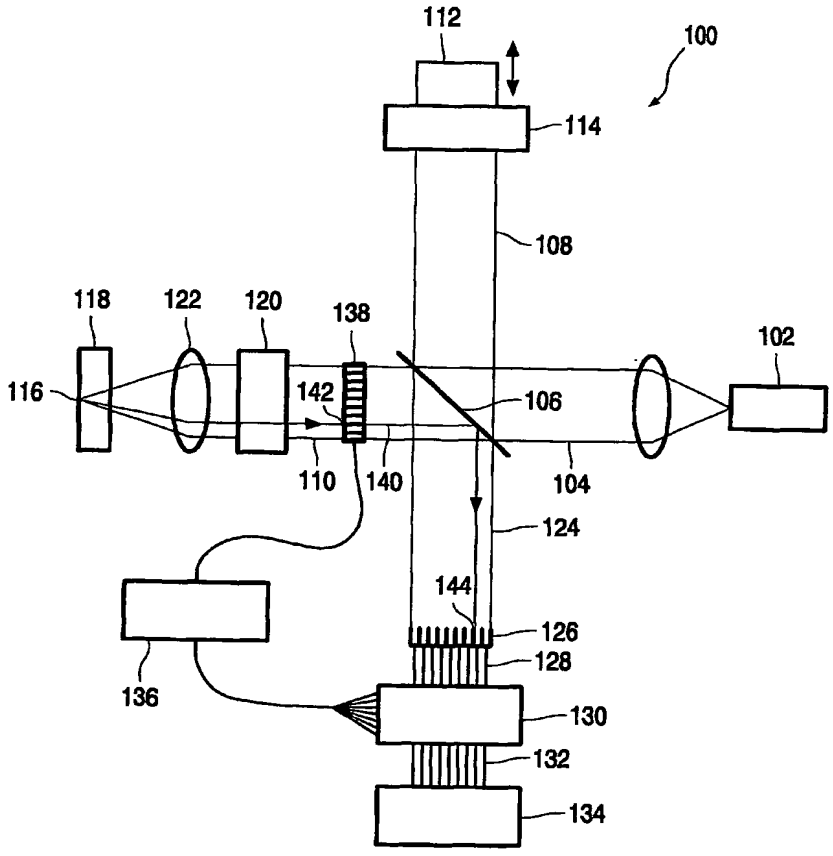
(54) Title: METHOD AND ARRANGEMENT FOR OPTICAL COHERENCE TOMOGRAPHY




(57) Abstract: The invention relates to a method for optical coherence tomography comprising the steps of: - providing of a reference light beam and a measurement light beam, - combining of the reference light beam and the measurement light beam to provide a combined light beam, - modulating of the reference light beam, - sampling of the combined light beam to measure an amplitude of an intensity variation for each sampling position, - adding of the amplitudes to provide an intensity signal for one picture element.- correcting deformations and aberrations either in the electronic, or in the optical domain

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